

Transaction Information

ToolId	4785151EQ
ToolStatus	Connected Idle
Location	Burlington
WaferSize	200 mm
FabSection	Reliability Lab,

General Product Information

VendorSupplier	ELECTROGLAS
Model	2001X
Vintage	1985
SerialNo	WMP91030195-141911
AssetDescription	ELECTROGLAS 2001X Semi Automatic Wafer Prober (Dead)
SoftwareVersion	
CIM	
Process	Wafer Test

Hardware Configuration (Fab)

SystemType	Description	Quantity	Status
Main System	SEMI AUTOMATIC PROBER	1	
Factory Interface	NONE		
Handler System	NONE		
Options System			
Others			

Hardware Configuration (Subfab / Auxilliary Units)

Description	Quantity	Status
NONE		

Missing/Faulty Parts / Accesories List

Description	Quantity
DEAD	

Tool Pictures

general

ELECTROGLAS 2001X Semi
Automatic Wafer Prober



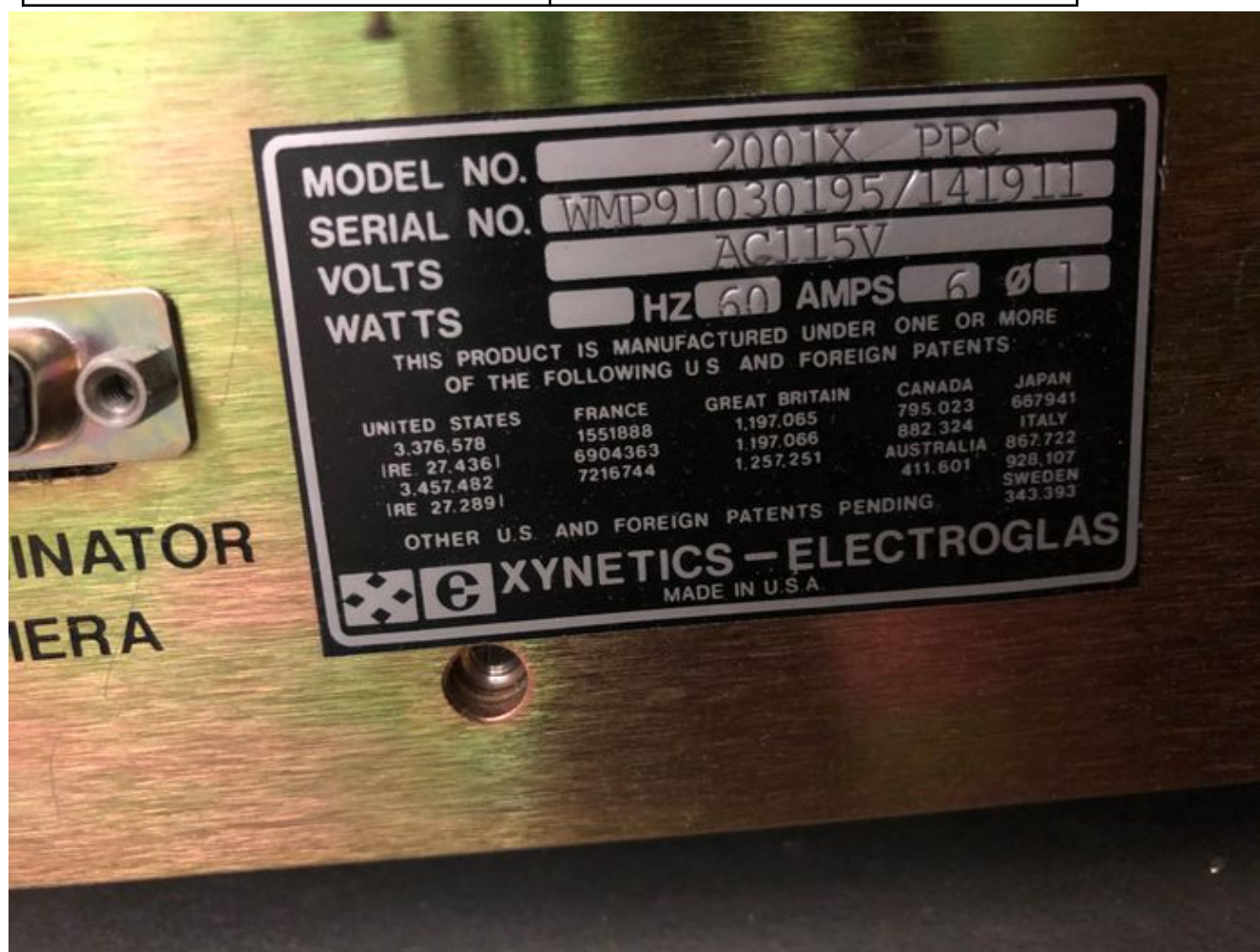
general

ELECTROGLAS 2001X Semi
Automatic Wafer Prober



general

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Additional Configuration Files